

DESCRIPTION

These N-Channel enhancement mode powerfield effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and energy pulse in the avalancheand commutation mode. These devices are well suited for high efficiencyfast switching applications.

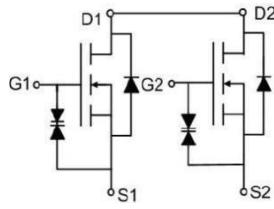
GENERAL FEATURES

- $V_{DS}=20V$, $I_D=9.5A$
- $R_{DS(ON)}(\text{Typ.})=7.6\text{m}\Omega$ @ $V_{GS}=4.5V$
- $R_{DS(ON)}(\text{Typ.})=11\text{m}\Omega$ @ $V_{GS}=2.5V$
- Fast switching
- G-S ESD protection diode embededd withstandhigh
- Green Device Available

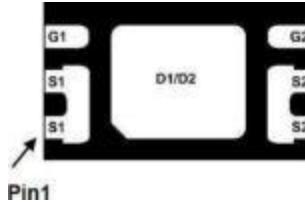
APPLICATION

- MB/VGA/Voore
- Portable Equipment
- Battery Powered System
- Load Switch
- LCD Display inverter

PINOUT



Schematic diagram



DFN2X3 & Pin Assignment

ORDERING INFORMATION

Part Number	Storage Temperature	Package	Devices Per Reel
MXN8204	-55°C to 150°C	DFN2X3	-

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	20	V
Gate-Source Voltage	V_{GS}	± 12	V
Drain Current-Continuous($T_C=25^\circ C$)	I_D	9.5	A
Drain Current-Continuous($T_C=70^\circ C$)	I_D	7.6	A
Pulsed Drain Current ^(Note2)	I_{DM}	60	A
Maximum Power Dissipation($T_A=25^\circ C$) ^(Note1)	P_D	1.56	W
Maximum Power Dissipation($T_A=70^\circ C$) ^(Note1)	P_D	1	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

THERMAL RESISTANCE

Thermal Resistance, Junction-to-Ambient ^(Note1)	$R_{\theta JA}$	80	°C/W
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Note 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, $t \leq 10\text{s}$.

Note 2. The data tested by pulsed , pulse width $\leq 10\text{us}$, duty cycle $\leq 1\%$


ELECTRICAL CHARACTERISTICS($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	20	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=16\text{V}, V_{GS}=0\text{V}$	-	-	1	μA
		$V_{DS}=16\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$	-	-	5	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=\pm 12\text{V}, V_{DS}=0\text{V}$	-	-	± 10	μA
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.45	-	1.5	V
Drain-Source On-State Resistance ^(Note1)	$R_{DS(\text{ON})}$	$V_{GS}=4.5\text{V}, I_D=5\text{A}$	6.3	7.6	9	$\text{m}\Omega$
		$V_{GS}=4.0\text{V}, I_D=5\text{A}$	6.5	8	9.5	$\text{m}\Omega$
		$V_{GS}=3.7\text{V}, I_D=5\text{A}$	6.7	8.2	10	$\text{m}\Omega$
		$V_{GS}=3.1\text{V}, I_D=5\text{A}$	7	9	11.2	$\text{m}\Omega$
		$V_{GS}=2.5\text{V}, I_D=5\text{A}$	8	11	13.5	$\text{m}\Omega$
Forward Trans Conductance	g_f	$V_{DS}=5\text{V}, I_D=5.5\text{A}$	-	38	-	S

Dynamic Characteristics

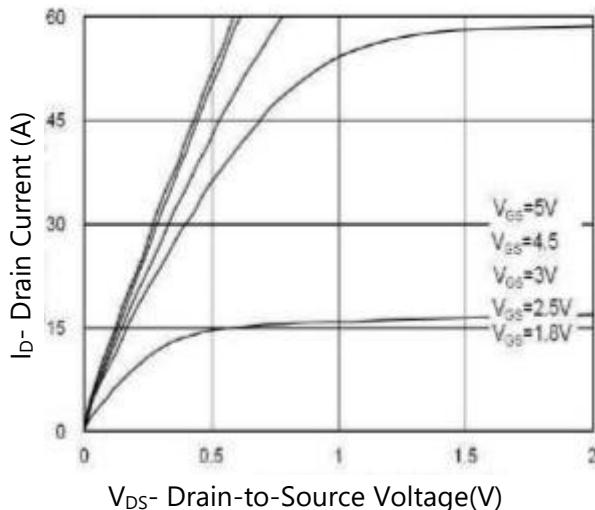
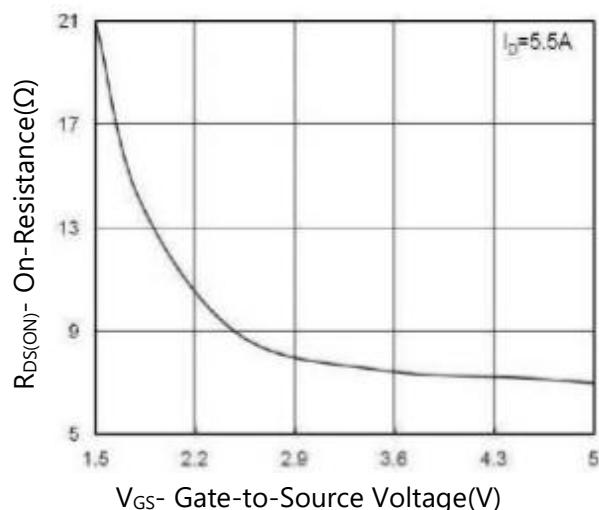
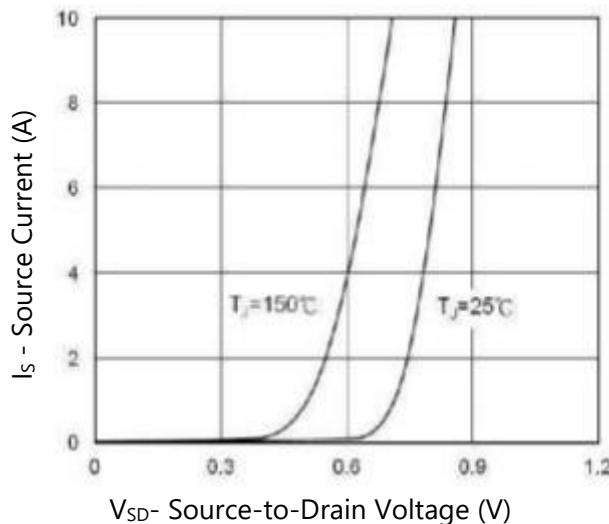
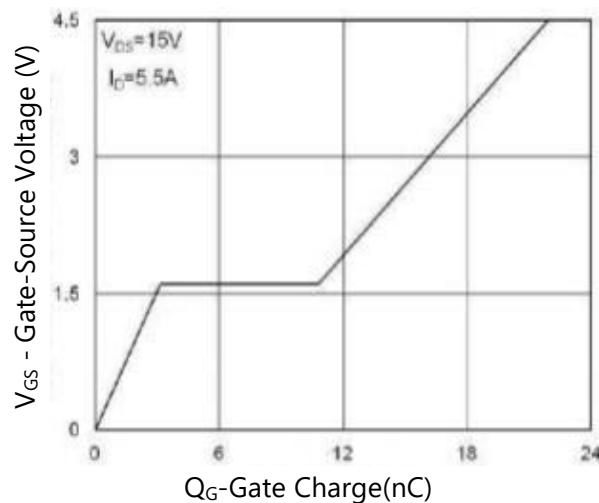
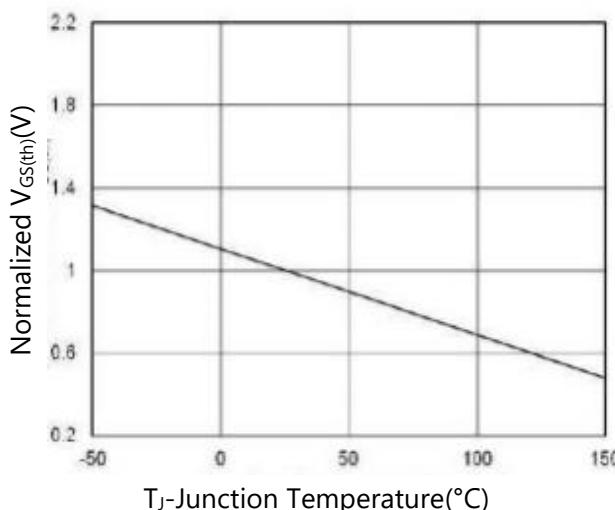
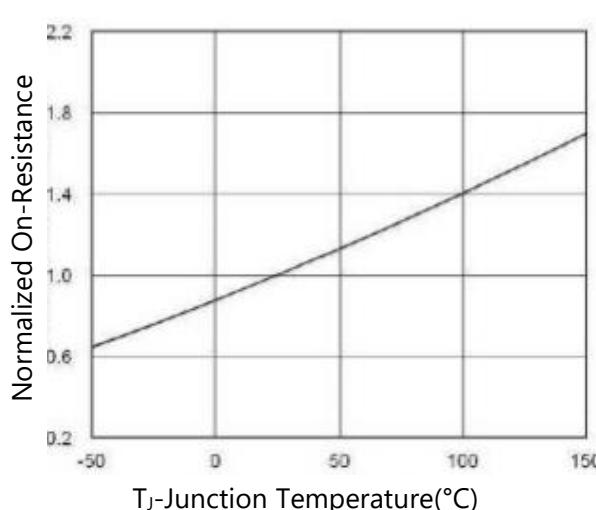
Input Capacitance	C_{iss}	$V_{DS}=10\text{V}, V_{GS}=0\text{V}, F=1.0\text{MHz}$	-	1647	-	pF
Output Capacitance	C_{oss}		-	170	-	pF
Reverse Transfer Capacitance	C_{rss}		-	148	-	pF
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=15\text{V}, V_{GS}=4.5\text{V}, R_G=6\Omega, I_D=5.5\text{A}$	-	10	-	nS
Turn-on Rise Time	t_r		-	39.5	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	65	-	nS
Turn-Off Fall Time	t_f		-	30	-	nS
Total Gate Charge	Q_g		-	22	-	nC
Gate-Source Charge	Q_{gs}	$V_{DS}=15\text{V}, I_D=5.5\text{A}, V_{GS}=4.5\text{V}$	-	3.1	-	nC
Gate-Drain Charge	Q_{gd}		-	8.2	-	nC

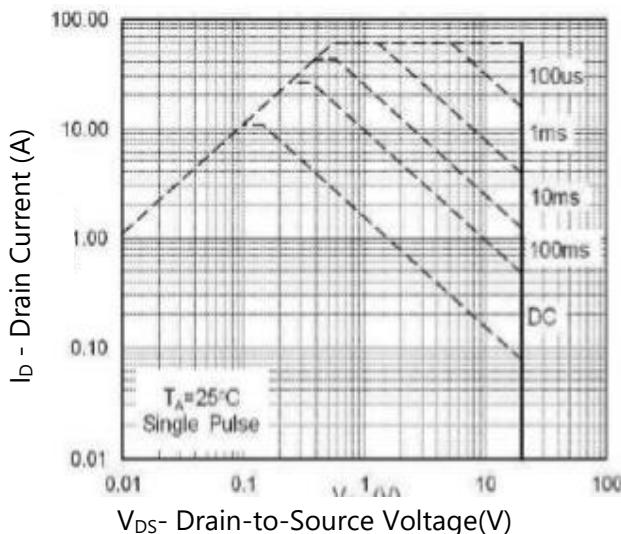
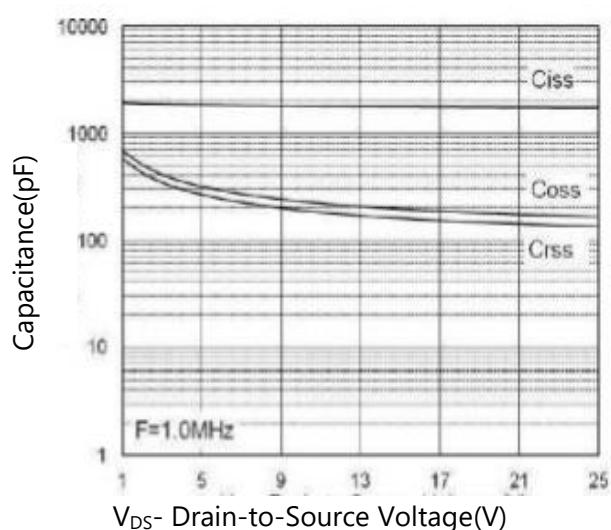
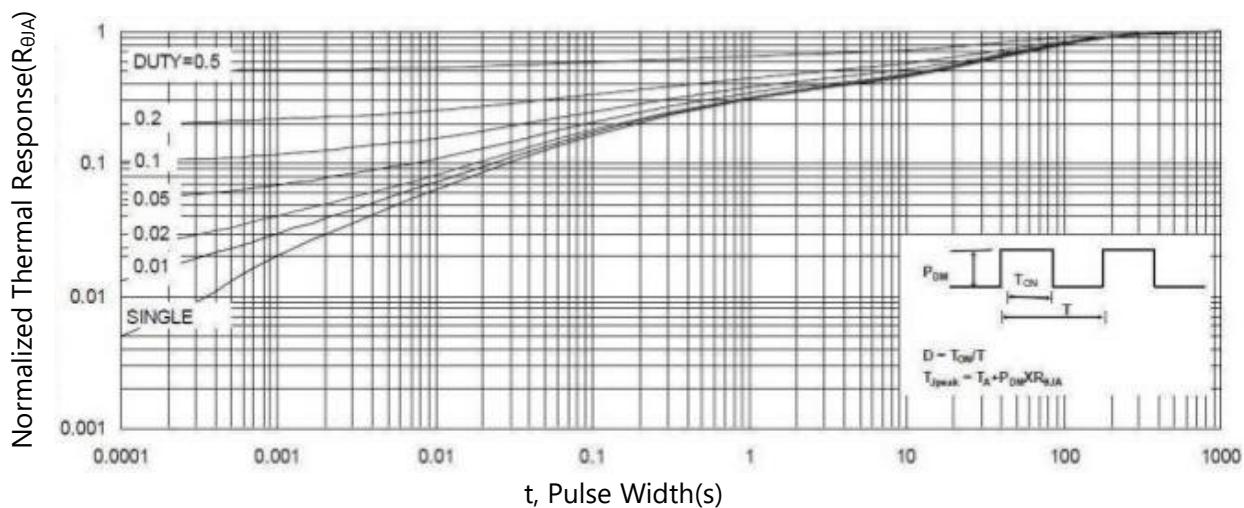
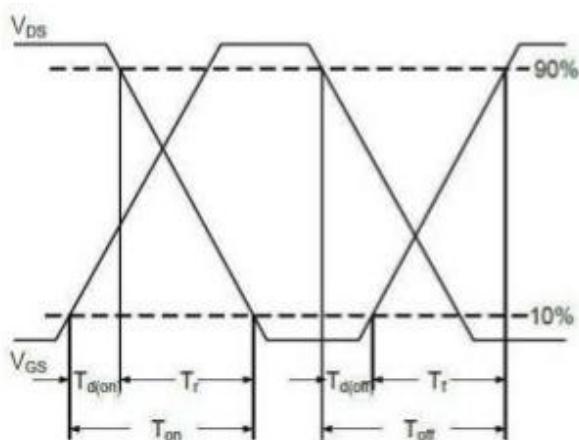
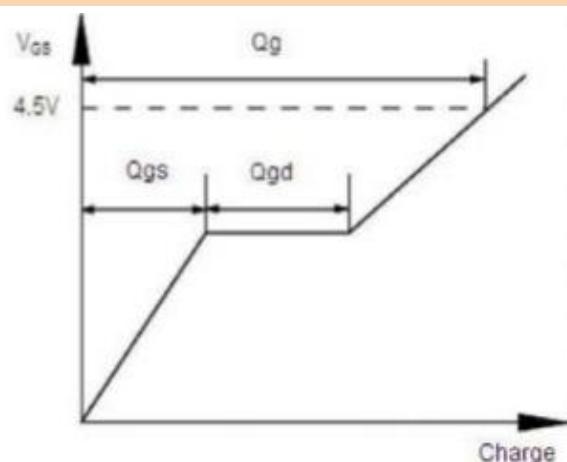
Drain-Source Diode Characteristics

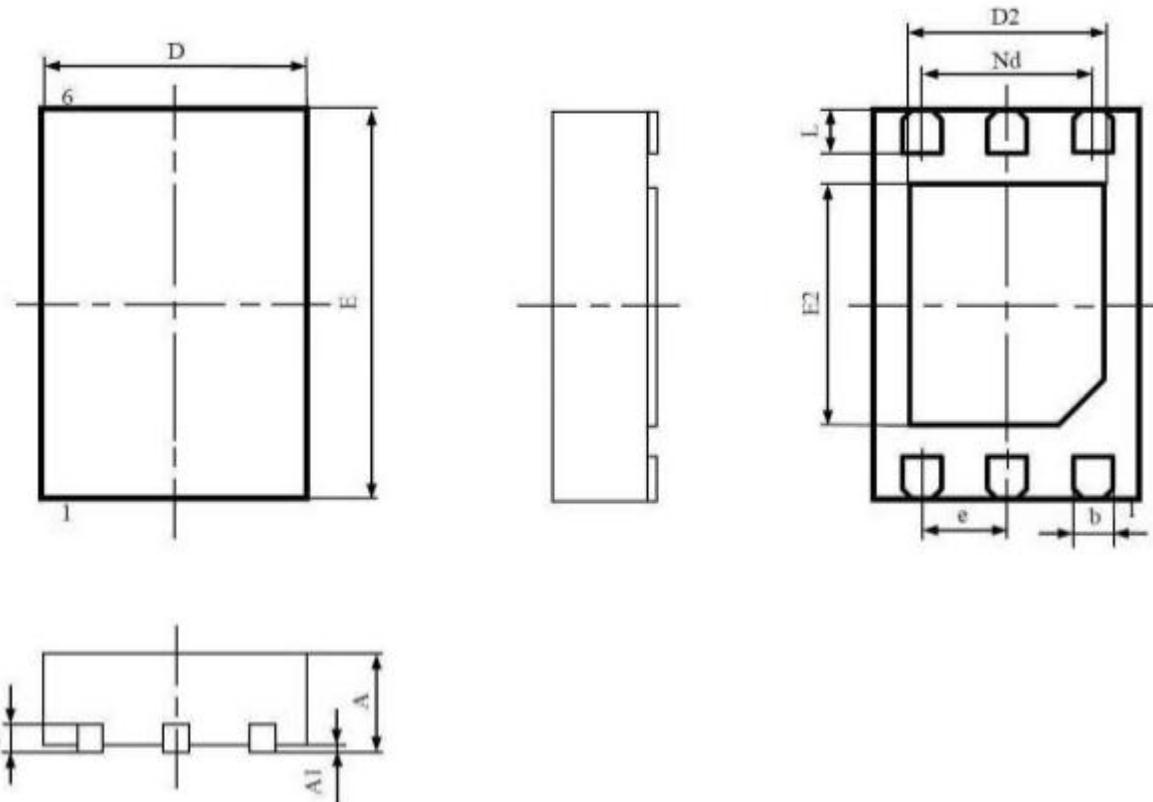
Diode Forward Voltage ^(Note2)	V_{SD}	$I_{IS}=9.5\text{A}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1.2	V
Maximum Body-Diode Continuous Current ^(Note1)					9.5	A

Note 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, $t \leq 10\text{s}$.

Note 2. The data tested by pulsed, pulse width $\leq 10\text{us}$, duty cycle $\leq 1\%$


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS
Figure 1. Output Characteristics

Figure 2. On-Resistance vs. Gate-Source

Figure 3. Source-Drain Diode Forward Voltage

Figure 4. Gate-Charge Characteristics

Figure 5. $V_{GS(th)}$ vs. Junction Temperature

Figure 6. $R_{DS(on)}$ vs. Junction Temperature



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS
Figure 7. Capacitance

Figure 8. Safe Operating Area

Figure 9. Normalized Maximum Thermal Transient Impedance

Figure 10. Switching Time Waveform

Figure 11. Gate Charge Waveform


PACKAGE INFORMATION
DFN2X3


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MIN	MAX	MIN	MAX
A	0.550	0.800	0.028	0.031
A1	0.02typ.	0.050	0.001typ.	0.002
b	0.200	0.350	0.008	0.014
c	0.180	0.250	0.007	0.010
D	1.900	2.100	0.075	0.083
D2	1.400	1.600	0.055	0.063
e	0.5BSC		0.02BSC	
Nd	1.0BSC		0.04BSC	
E	2.900	3.100	0.114	0.122
E2	1.650	1.750	0.065	0.069
L	0.300	0.400	0.012	0.016